Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	er
10/748,931	OH ET AL.	•
Examiner	Art Unit	
Jean F. Duverne	2839	

SEARCHED			
Class	Subclass	Date	Examiner
439	73	2/3/2005	JFD
	152	2/3/2005	JFD
	330	2/3/2005	JFD .
	525	2/3/2005	JFD
	591	2/3/2005	JFD
	296	2/3/2005	JFD
	72	2/3/2005	JFD
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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